

Search Notes

Application/Control No.

10/783,596

Examiner

Benny Lee

Applicant(s)/Patent under
Reexamination

LIN ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
333	1, 4, 5	7/22/2005	BTL
Rsch	above	12/23/2005	BTL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
333	1, 5	12/30/2005	BTL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR